

RFI MEASUREMENT TEST REPORT FCC PART 15B CLASS B

****** CLASS B DIGITAL DEVICES AND PERIPHERALS ********

APPLICANT : <u>SEIKO EPSON CORPORATION</u>

EQUIPMENT : **PRINTER**

TRADE NAME : EPSON

MODEL NUMBER : P912A

FCC ID NUMBER : BKMFBP912A

TEST REPORT No. : <u>E-103-98229</u>



NVLAP LAB CODE 200157-0

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TEST CERTIFICATION

Applicant Information

Company : SEIKO EPSON Corporation

Division/Section : TP Product Safety Design Group

Imaging & Information Products Operations

Address : 80, Harashinden, Hirooka, Shiojiri-shi, Nagano, 399-0785 Japan

PHONE: +81-263-53-6024 FAX: +81-263-53-3544

Test Performed

Company : SEIKO EPSON Corporation

Division/Section : EMC Group, CS/Quality Assurance Office

Location : 80, Harashinden, Hirooka, Shiojiri-shi, Nagano, 399-0785 Japan

PHONE: +81-263-52-5094 FAX: +81-263-54-5806

10 meter Semi-anechoic Chamber

FCC File No. : 31040 / SIT 1300F2

NVLAP Lab Code: 200157-0

Test started : 31 August, 1998

Test completed : 7 September, 1998

Purpose of test : Compliance with standards

Test specification(s) : FCC Part 15B Class B (Unintentional Radiators)

Test procedure(s) : ANSI C63.4-1992

Test engineer : Toshiyuki Omori _____

EMC group, CS/Quality Assurance Office

Report checked by : Atsushi Shinozaki

Chief Engineer, EMC group, CS/Quality Assurance Office

Report approved by : Yoshiyuki Sakurai

Manager, EMC group, CS/Quality Assurance Office, NVLAP signatory

Report issue date : 9 September, 1998

The test item under the test conditions and configuration shown in this test report complies with above standard.

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1. DETAILED DESCRIPTION OF TEST ITEM

1-1 Equipment Under Test (EUT)

Kind of equipment : Printer

Shape : Table-top type

Manufacturer : SEIKO EPSON Corporation

Trade Name : EPSON Model Number : P912A

FCC ID : BKMFBP912A

Serial Number : 000001

Voltage input : AC 120 V / 60 Hz

Rated current : 1.1 A

Port(s) / Connector(s) : Parallel (Centronics)

Serial (RS-232C, optional)

Oscillator(s) / Crystal(s) : 19.66 MHz Maximum used frequency : 19.66 MHz

Remarks : With serial I/F card (C82305), cut-sheet feeder (C806731)

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1-2 Auxiliary equipment (AE)

ΛE	Name	Model (Serial number)	Manufacturer	FCC ID	Voltage input Power consumption	
1	Serial I/F card	C82305 (N/A)	SEIKO EPSON Corp.	BKMC82305	DC 5.0 V 50 mA	a) b)_
2	Cut-sheet feeder	C806731 (000073)	SEIKO EPSON Corp.	N/A	DC 35 V 900 mA DC 5.0 V 170 mA	a) b)
3	Personal computer	D3394B (SG60400940)	Hewlett-Packard	K4UVECTRAVL5	AC 120 V/ 60 Hz 3.0 A	
1	CRT monitor	D2806B (KR54586408)	Hewlett-Packard	CSYSC-528UXH	AC 120 V/ 60 Hz 3.0 A	
5	Keyboard	C3755B (60552408)	Hewlett-Packard	AQ6ZG-RT687XT	DC 5.0 V 300 mA	(c)
6	Mouse	M-S34 (LZA63501449)	Hewlett-Packard	DZL211029	DC 5.0 V 15 mA	(c)
7	Printer	P850A (1YLY185764)	SEIKO EPSON Corp.	BKMP850A	AC 120 V/ 60 Hz 1.0 A	

- a) EUT option
- b) Supplied from EUT
- c) Supplied from AE3

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1-3 Relevant Signal and Power lines

AE = Auxiliary equipment, EUT = Equipment Under Test = Test item

Line	Name	From	То	Length	Shield	Remarks
1	Parallel I/F cable	EUT Parallel in / AE7 Parallel in	AE3 Parallel out	2.0 m	Yes	Metal connector
2	Scrial I/F cable	AE1 Serial in / AE7 Serial in	AE3 Serial out	2.0 m	Yes	Metal connector
_3	Cut-sheet feeder I/F	AE2 Signal in	EUT Signal out	0.2 m	Yes	Metal connector
4	Video I/F cable	AE4 Video in	AE3 Video out	1.4 m	Yes	Metal connector
_ 5	Keyboard I/F cable	AE5 Keyboard	AE3 Keyboard out	2.9 m	Yes	Metal connector
6	Mouse I/F cable	AE6 Mouse	AE3 Mouse out	1.8 m	Yes	Metal connector
7	EUT AC cable	EUT AC 120 V in	Main AC 120 V	1.9 m	No	
8	Computer AC cable	AE3 AC 120 V in	Main AC 120 V	1.9 m	No	
9	Monitor AC cable	AE4 AC 120 V in	Main AC 120 V	1.9 m	No	
10	Printer AC cable	AE7 AC 120 V in	Main AC 120 V	1.9 m	No	

Note: Line 3 (Cut-sheet feeder I/F) has a ferrite core permanently attached.

Line 4 (Video I/F cable) has a ferrite core permanently attached.

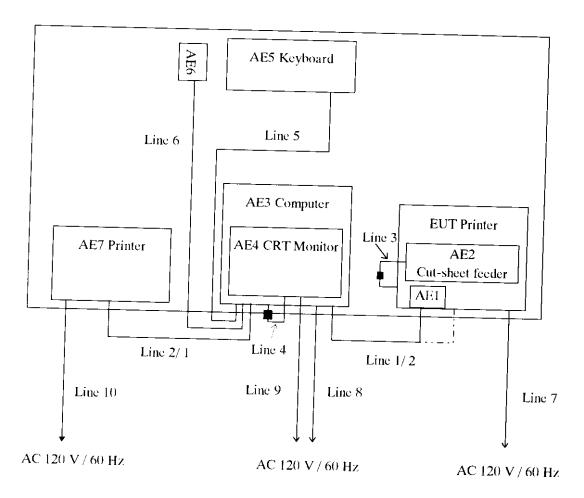


1-4 Positioning of Equipment

The positioning of EUT during testing is as follows.

■ : Ferrite Core

Testing table top view



Abbreviations shown in the above diagram correspond to equipment or cables in Section 1-1, 1-2, 1-3.

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2. OPERATING CONDITIONS

The EUT has been operated under the following conditions during the tests.

2-1 Operating modes

Mode 1: Parallel interface mode

The EUT continuously prints character 'H' via the parallel interface (line 1) with below operating cycles.

Mode 2 : Serial interface mode

The EUT continuously prints character 'H' via the serial interface (line 2) with below operating cycles.

2-2 Operating cycles

Performed following operation continuously.

- 1: The Data transferred from computer(AE3)
- 2: 'H' characters printed by EUT
- 3: 'H' characters displayed on the full screen of monitor (AE4)
- 4: 'H' characters printed by printer (AE7)

Note The data transfer rate on the serial I/F (RS-232C)is 9600 bps.

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3. TEST PROCEDURE(S)

These tests have been carried out with the test procedure(s) drawn up by our laboratory based on the following test procedure(s).

Test Item	Test procedure used	Scanned Frequency Rang
Conducted Emission	ANSI C63.4 - 1992	0.45 - 30 MHz
Radiated Emission	ANSI C63.4 - 1992	30 - 1000 MHz
	13.51 5.611 1992	20 - 1000 MHX

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4. EVALUATION OF TEST RESULTS

4-1 Conducted Emission Test

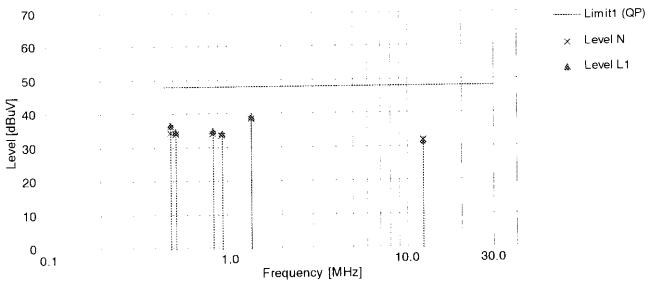
Mode 1: Parallel interface

22 °C Temperature Kind of Equipment Printer % 55 Humidity P912A Model Name Engineer T. Omori 000001 Serial No.

Parallel I/F Comment

Date 98/8/31 QP Detector R/S ESH 2 EMI Receiver(s) 6 **Points**

Limit1: [FCC] Class B



Read	ing N	Read	ing L1	QP-AVE	QP/AVE	Correction	Level N	Level L1	Limit	Margin
QP	AVE	QP	AVE		-13	Factor				
ſdBu√l	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]	[dB]	[dBuV]	[dBuV]	[dBuV]	[dB]
		36.3	-	-	-	0.2	34.4	36.5	48.0	11.5
		34.3		-	-	0.2	34.0	34.5	48.0	13.5
	_	34.7	-	-	-	0.1	33.9	34.8	48.0	13.2
				-	-	0.1	33.3	33.9	48.0	14.1
ļ	_					0.1	38.4	38.9	48.0	9.1
	<u> </u>	-			_	0.9	31.6	31.5	48.0	16.4
		[dBuV] [dBuV] 34.2 - 33.8 - 33.8 - 33.2 - 38.3 -	QP AVE QP [dBuV] [dBuV] [dBuV] 34.2 - 36.3 33.8 - 34.3 33.8 - 34.7 33.2 - 33.8 38.3 - 38.8	QP AVE QP AVE [dBuV] [dBuV] [dBuV] [dBuV] 34.2 - 36.3 - 33.8 - 34.3 - 33.8 - 34.7 - 33.2 - 33.8 - 38.3 - 38.8 -	QP AVE QP AVE [dBuV] [dBuV] [dBuV] [dBuV] [dB] 34.2 - 36.3 - - 33.8 - 34.3 - - 33.8 - 34.7 - - 33.2 - 33.8 - - 38.3 - 38.8 - -	QP AVE QP AVE -13 [dBuV] [dBuV] [dBuV] [dBuV] [dB] [dB] 34.2 - 36.3 - - - 33.8 - 34.3 - - - 33.8 - 34.7 - - - 33.2 - 33.8 - - - 38.3 - 38.8 - - -	QP AVE [dBuV] QP [dBuV] AVE [dBuV] -13 [dB] Factor [dB] 34.2 - 36.3 - - - 0.2 33.8 - 34.3 - - - 0.2 33.8 - 34.7 - - 0.1 33.2 - 33.8 - - 0.1 38.3 - 38.8 - - 0.1	QP AVE QP AVE -13 Factor [dBuV] [dBuV] [dBuV] [dB] [QP AVE QP AVE -13 Factor [dBuV] [dBuV] [dBuV] [dB] [dB] [dB] [dB] [dBuV] [dBuV]	Reading N Reading E1 QF AVE AVE -13 Factor Factor GBuV [dBuV] [dBuV] </td

Note :All other frequencies in the range from 450 kHz to 30 MHz have emission level of more than 10 dB below the limit.

Level = Reading + Correction Factor

Correction Factor = LISN factor + Cable Loss

Level is rounded off to one decimal place.

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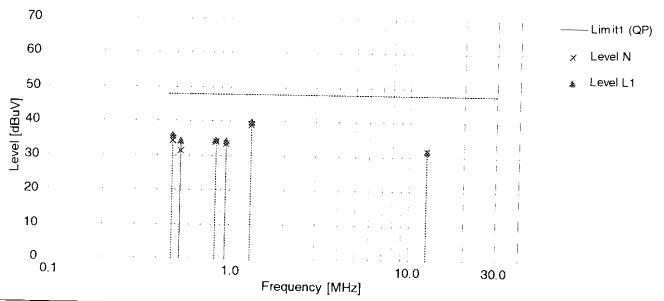
Mode 2 : Serial interface

Kind of Equipment Printer Temperature 22 °C Model Name P912A Humidity 55 % Serial No. 000001 Engineer T. Omori Comment Serial I/F

 Detector
 : QP
 Date
 : 98/8/31

 Points
 : 6
 EMI Receiver(s)
 : R/S ESH 2

Limit1 : [FCC] Class B



Frequency	Reading N		Read	ing L1	QP-AVE	QP/AVE	Correction	Level N	Level L1	Limit	Margin
	QP	AVE	QP	AVE		-13	Factor	2010,11	Leverer	E111146	Ivargin
[MHz]	[dBuV]	[dBuV]	[dBuV]	[dBuV]	[dB]	[dB]	[dB]	[dBuV]	 [dBuV]	l [dBuV]	[dB]
0.4837	34.2	-	35.8	-	-	=	0.2	34.4	36.0	48.0	12.0
0.5366	31.3	-	34.0		-	-	0.2	31.5	34.2	48.0	13.8
0.8373	33.8	-	34.5	-	-	-	0.1	33.9	34.6	48.0	13.4
0.9522	33.2	-	34.3	-	-		0.1	33.3	34.4	48.0	
1.3220	38.8	-	39.7				0.1	38.9			13.6
12.3257	30.7	_	30.8	_					39.8	48.0	8.2
				1	1		0.9	31.6	31.7	48.0	16.3

Note :All other frequencies in the range from 450 kHz to 30 MHz have emission level of more than 10 dB below the limit.

Level = Reading + Correction Factor

Correction Factor = LISN factor + Cable Loss

Level is rounded off to one decimal place.

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4-3 Radiated Emission Test

40 50

100

Mode 1: Parallel interface Kind of Equipment: Printer Temperature 22 °C Model Name P912A Humidity 55 % Serial No. 000001 Engineer : T. Omori Comment Parallel I/F Detector QP Date 1998/9/7 9:34 **Points** 6 EMI Receiver(s) ESS Limit1: [FCC] Class B<3m> 60 Limit1(QP) Horizontal 50 Vertical Horizontal Vertical 40 Host computer ₹ Level[dBuV/m] 30 20

Frequency [MHz]	Meter Reading [dBuV]	Ant. Type	Antenna Factor [dB]	Total Loss [dB]	Level [dBuV/m]	Angle [degree]	Height [cm]	Pola.	Limit [dBuV/m]	Margin [dB]
30.015	30.5	BC	19.3	-20.5	29.3	206	100	Vert.	40.0	10.7
49.249	33.4	BC	11.9	-19.8	25.5	264	100	Vert.	40.0	14.5
108.344	33.5	BC	11.2	-18.8	25.9	355	292	Hori.	43.5	17.6
190.993	30.9	вс	16.5	-17.8	29.6	288	208	Hori.	43.5	13.9
640.099	26.0	LP	18.9	-14.3	30.6	214	100	Vert.	46.0	15.4
640.192	24.5	LP	18.9	-14.3	29.1	236	100	Hori.	46.0	16.9

200

Frequency[MHz]

300

500

700

1000

Note: All other frequencies in the range from 30 MHz to 1000 MHz have emission level of more than 10 dB below the limit.

Level = Meter Reading + Antenna Factor + Total Loss (Total Loss = Cable Loss + Antenna Pad Loss - Amplifier Gain)

Level is rounded off to one decimal place.

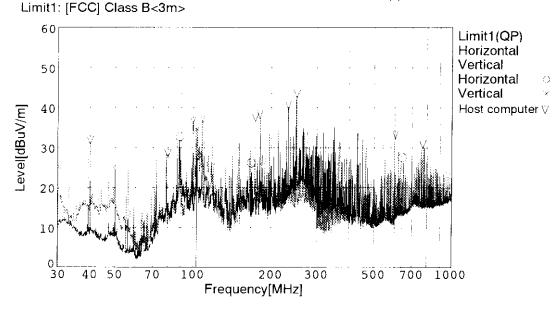
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Mode 2 : Serial interface

Kind of Equipment: Printer Temperature : 22 °C Model Name : P912A Humidity : 55 % Serial No. : 000001 Engineer : T. Omori Comment : Serial I/F

Detector : QP Date : 1998/9/7 10:32

Points : 8 EMI Receiver(s) : ESS



Frequency [MHz]	Meter Reading [dBuV]	Ant. Type	Antenna Factor [dB]	Total Loss [dB]	Level [dBuV/m]	Angle [degree]	Height [cm]	Pola.	Limit [dBuV/m]	Margin [dB]
30.145	26.5	вс	19.2	-20.5	25.2	83	100	Vert.	40.0	14.8
49.252	32.9	вс	11.9	-19.8	25.0	11	100	Vert.	40.0	15.0
88.645	44.0	ВC	7.9	-19.1	32.8	187	325	Hori.	43.5	10.7
103.221	36.5	вс	10.4	-18.9	28.0	149	208	Hori.	43.5	15.5
103.438	43.0	вс	10.4	-18.8	34.6	281	100	Vert.	43.5	8.9
167.440	28.5	вс	15.8	-18.2	26.1	0	188	Hori.	43.5	17.4
640.215	23.5	LP	18.9	-14.3	28.1	204	100	Vert.	46.0	17.9
640.217	23.0	LP	18.9	-14.3	27.6	240	207	Hori.	46.0	18.4

Note: All other frequencies in the range from 30 MHz to 1000 MHz have emission level of more than 10 dB below the limit.

Level = Meter Reading + Antenna Factor + Total Loss (Total Loss = Cable Loss + Antenna Pad Loss - Amplifier Gain)

Level is rounded off to one decimal place.

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6. LIST OF UTILIZED TEST EQUIPMENT

6-1 Conducted Emission Measurement

Instrument	Manufacturer	Model Number	Serial Number	Last Calibration Date	Period
Spectrum Analyzer	Hewlett Packard	8567A	2718A00363	April 28, 1998	1 Year
Quasi-peak Adapter	Hewlett Packard	85650A	2521A00798	April 3, 1998	1 Year
Test Receiver	Rhode & Schwarz	ESH2	879013/027	April 1, 1998	l Year
LISN	Rhode & Schwarz	ESH3-Z5	892785/012	June 25, 1998	l Year

6-2 Radiated Emission Measurement

Instrument	Manufacturer	Model	Serial	Last Calibration		
		Number	Number	Date	Period	
Spectrum Analyzer	Hewlett Packard	8566B	2332A02675	August 24, 1998	1 Year	
Quasi-peak Adapter	Hewlett Packard	85650A	2043A00284	- August 24, 1998	1 Year	
Pre-amplifier	Hewlett-Packard	87405A	3207A00888	March 18,1998	1 Year	
Test Receiver	Rhode & Schwarz	ESS	845420/010	January 8, 1998	1 Year	
Biconical Antenna	Schwarzbeck	BBA9106	-	February 11, 1998	l Year	
Log-periodic Antenna	EMCO	3146	8910-2511	November 24, 1997	1 Year	

Note: The utilized instruments are calibrated by a body that can provide traceability to a national standard.

The abbreviation of antenna types which indicate on the radiated emission test table are follows:

BC : Biconical Antenna LP : Log-periodic Antenna

6-3 Measurement Uncertainties

Measurement uncertainties are shown as below.

Conducted Emission Measurement

 $\pm 2.33 \text{ dB}$

Radiated Emission Measurement

 $5.15 \, dB / = 4.56 \, dB$

Repeating and reproducing maximum emission set-up are not discussed herein.

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7. VALIDITY OF TEST REPORT

- 1: The test result of this report is effective for equipment under test itself and test configuration described on the report.
- 2: This test report shall not be reproduced without the written approval of the laboratory.
- 3: This test report must not be used by client to claim product endorsement by NVLAP or any agency of the U.S. Government.

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8. DESCRIPTION OF TEST LABORATORY

Bibliography

Since commencing operation in 1942 as a watch manufacturer, Seiko Epson Corporation has utilized its own original micromechatronics technologies, gained while developing quartz watches, to diversify into a variety of fields, as computers, printers and electronic devices, including semiconductors and liquid crystal displays. The phase "highly functional and highly compact" best describes the policy of our product development activities.

Since the initial electrical printer was manufactured in 1971, Seiko Epson Corporation has been working for EMC field. It is a combination of precise machine technology and electric technology.

Now EMC group has 3 semi-anechoic chambers and 8 EMI/EMC test facilities and full responsibilities on EMC testing. It is independent from any other business organizations and admired by the president as neutral and it's independency.

Filing, Certification and Accreditation List

EMC testing

FCC (USA)

NVLAP (Lab. Code: 200157-0) (USA)

NMi (Netherlands)

VCCI (Japan)

NEMKO (Norway)

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5. SUMMARY

5-1 Test Results

This test report clearly shows that the EUT complies with the FCC Part 15B Class B specification.

The minimum margins to the limits are as follows:

- Conducted measurement

8.2 dB

at

1.3220 MHz (Mode 2)

- Radiation measurement

8.9 dB

103.438 MHz (Mode 2)

This data represent the worst case emissions.

5-2 Sample Calculations

5-2-1 Conducted Emission

Example 1.3220 MHz (Mode 2)

Emission Level =

Meter Reading

39.7 dBuV

+ Correction Factor

0.1dB

39.8 dBuV

Margin = Limit 48.0 dBuV

Emission Level

39.8 dBuV

8.2 dB

Meter reading = Test receiver reading

The numerical value are rounded off to one decimal place.

5-2-2 Radiated Emission

Example 103.438 MHz (Mode 2)

Emission Level = Meter Reading

43.0 dBuV

Antenna Factor

10.4 dB

Total Loss

18.8 dB

34.6 dBuV/m

Margin =

Limit

43.5 dBuV/m

Emission Level

34.6 dBuV/m

= 8.9 dΒ

Meter reading = Test Receiver reading

The numerical values are rounded off to one decimal place.